

Notice of References Cited

Application/Control No.

Applicant(s)/Patent Under Reexamination HUI ET AL.

Examiner

Khiem D Nguyen

Applicant(s)/Patent Under Reexamination HUI ET AL.

Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,270,265	12-1993	Hemmenway et al.	438/404
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	С	US-			
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	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
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